

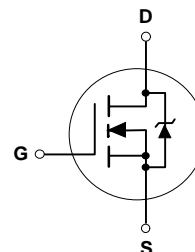
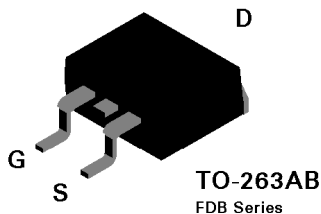
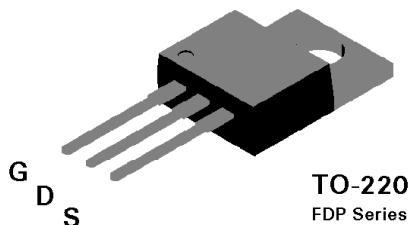
## FDP6035L/FDB6035L N-Channel Logic Level Enhancement Mode Field Effect Transistor

### General Description

These N-Channel logic level enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage applications such as DC/DC converters and high efficiency switching circuits where fast switching, low in-line power loss, and resistance to transients are needed.

### Features

- 58 A, 30 V.  $R_{DS(ON)} = 0.011 \Omega @ V_{GS}=10 V$   
 $R_{DS(ON)} = 0.019 \Omega @ V_{GS}=4.5 V$ .
- Low gate charge (typical 34 nC).
- Low  $C_{rss}$  (typical 175 pF).
- Fast switching speed.



### Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

| Symbol         | Parameter   | FDP6035L   | FDB6035L | Units |
|----------------|---|------------|----------|-------|
| $V_{DSS}$      | Drain-Source Voltage  | 30         |          | V     |
| $V_{GSS}$      | Gate-Source Voltage   | ±20        |          | V     |
| $I_D$          | Drain Current - Continuous<br>- Pulsed  | 58         |          | A     |
|                |   | 175        |          |       |
| $P_D$          | Maximum Power Dissipation @ $T_C = 25^\circ\text{C}$<br>Derate above $25^\circ\text{C}$ | 75         |          | W     |
|                |   | 0.5        |          |       |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range   | -65 to 175 |          | °C    |

### THERMAL CHARACTERISTICS

| Symbol          | Parameter                               | FDP6035L | FDB6035L | Units |
|-----------------|---|----------|----------|-------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case    | 2        |          | °C/W  |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | 62.5     |          | °C/W  |

**Electrical Characteristics**  $T_c = 25^\circ\text{C}$  unless otherwise noted)

| Symbol   | Parameter   | Conditions   | Min | Typ    | Max   | Unit          |
|--|---|--|-----|--------|-------|---------------|
| <b>DRAIN-SOURCE AVALANCHE RATINGS</b> (Note 1) |   |  |     |        |       |               |
| $W_{DSS}$                                      | Single Pulse Drain-Source Avalanche Energy            | $V_{DD} = 15\text{ V}, I_D = 21\text{ A}$                            |     |        | 150   | mJ            |
| $I_{AR}$                                       | Maximum Drain-Source Avalanche Current                |  |     |        | 21    | A             |
| <b>OFF CHARACTERISTICS</b>                     |   |  |     |        |       |               |
| $BV_{DSS}$                                     | Drain-Source Breakdown Voltage                        | $V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$                        | 30  |        |       | V             |
| $\Delta BV_{DSS}/\Delta T_J$                   | Breakdown Voltage Temp. Coefficient                   | $I_D = 250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$          |     | 37     |       | mV/°C         |
| $I_{DSS}$                                      | Zero Gate Voltage Drain Current                       | $V_{DS} = 24\text{ V}, V_{GS} = 0\text{ V}$                          |     |        | 10    | $\mu\text{A}$ |
| $I_{GSSF}$                                     | Gate - Body Leakage, Forward                          | $V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$                          |     |        | 100   | nA            |
| $I_{GSSR}$                                     | Gate - Body Leakage, Reverse                          | $V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$                         |     |        | -100  | nA            |
| <b>ON CHARACTERISTICS</b> (Note 1)             |   |  |     |        |       |               |
| $V_{GS(th)}$                                   | Gate Threshold Voltage                                | $V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$                            | 1   | 1.6    | 3     | V             |
| $\Delta V_{GS(th)}/\Delta T_J$                 | Gate Threshold Voltage Temp. Coefficient              | $I_D = 250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$          |     | -4     |       | mV/°C         |
| $R_{DS(on)}$                                   | Static Drain-Source On-Resistance                     | $V_{GS} = 10\text{ V}, I_D = 26\text{ A}$                            |     | 0.0095 | 0.011 | $\Omega$      |
|  |   | $T_J = 125^\circ\text{C}$  |     | 0.014  | 0.019 |               |
|  |   | $V_{GS} = 4.5\text{ V}, I_D = 21\text{ A}$                           |     | 0.015  | 0.019 |               |
| $I_{D(on)}$                                    | On-State Drain Current                                | $V_{GS} = 10\text{ V}, V_{DS} = 10\text{ V}$                         | 60  |        |       | A             |
| $I_{D(on)}$                                    | On-State Drain Current                                | $V_{GS} = 4.5\text{ V}, V_{DS} = 10\text{ V}$                        | 15  |        |       | A             |
| $g_{FS}$                                       | Forward Transconductance                              | $V_{DS} = 10\text{ V}, I_D = 26\text{ A}$                            |     | 37     |       | S             |
| <b>DYNAMIC CHARACTERISTICS</b>                 |   |  |     |        |       |               |
| $C_{iss}$                                      | Input Capacitance                                     | $V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V},$<br>$f = 1.0\text{ MHz}$ |     | 1230   |       | pF            |
| $C_{oss}$                                      | Output Capacitance                                    |  |     | 640    |       | pF            |
| $C_{riss}$                                     | Reverse Transfer Capacitance                          |  |     | 175    |       | pF            |
| <b>SWITCHING CHARACTERISTICS</b> (Note 1)      |   |  |     |        |       |               |
| $t_{D(on)}$                                    | Turn - On Delay Time                                  | $V_{DD} = 15\text{ V}, I_D = 58\text{ A}$                            |     | 7.6    | 15    | nS            |
| $t_r$  | Turn - On Rise Time                                   | $V_{GS} = 10\text{ V}, R_{GEN} = 24\ \Omega$                         |     | 150    | 210   | nS            |
| $t_{D(off)}$                                   | Turn - Off Delay Time                                 |  |     | 29     | 46    | nS            |
| $t_f$  | Turn - Off Fall Time                                  |  |     | 17     | 27    | nS            |
| $Q_g$  | Total Gate Charge                                     | $V_{DS} = 12\text{ V}$<br>$I_D = 58\text{ A}, V_{GS} = 10\text{ V}$  |     | 34     | 46    | nC            |
| $Q_{gs}$                                       | Gate-Source Charge                                    |  |     | 6      |       | nC            |
| $Q_{gd}$                                       | Gate-Drain Charge                                     |  |     | 8      |       | nC            |
| <b>DRAIN-SOURCE DIODE CHARACTERISTICS</b>      |   |  |     |        |       |               |
| $I_S$  | Maximum Continuous Drain-Source Diode Forward Current |  |     |        | 58    | A             |
| $V_{SD}$                                       | Drain-Source Diode Forward Voltage                    | $V_{GS} = 0\text{ V}, I_S = 26\text{ A}$ (Note 1)                    |     | 0.91   | 1.3   | V             |
|  |   | $T_J = 125^\circ\text{C}$  |     | 0.8    | 1.2   |               |

Note:

 1. Pulse Test: Pulse Width  $\leq 300\ \mu\text{s}$ , Duty Cycle  $\leq 2.0\%$ .

## Typical Electrical Characteristics

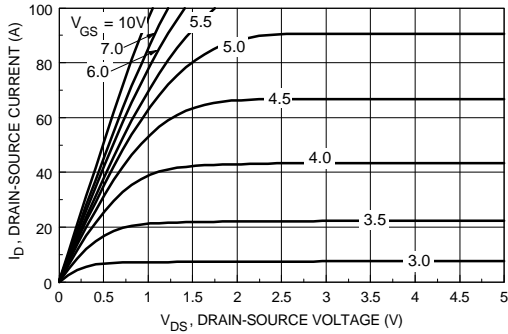


Figure 1. On-Region Characteristics.

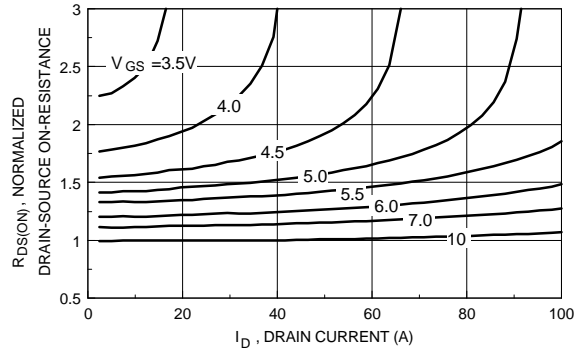


Figure 2. On-Resistance Variation with Drain Current and Gate

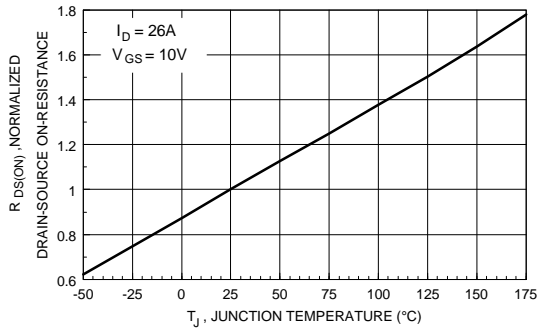


Figure 3. On-Resistance Variation with Temperature.

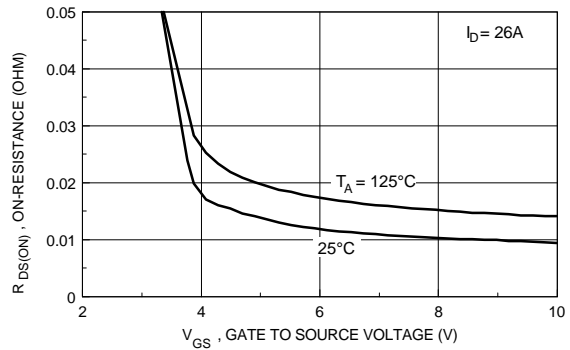


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

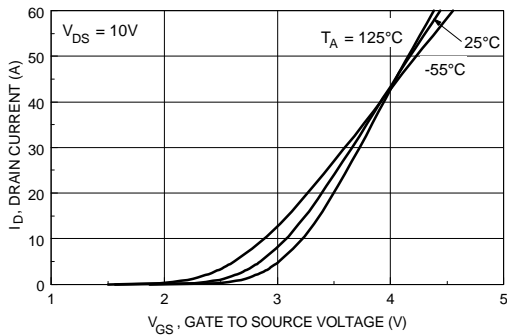


Figure 5. Transfer Characteristics.

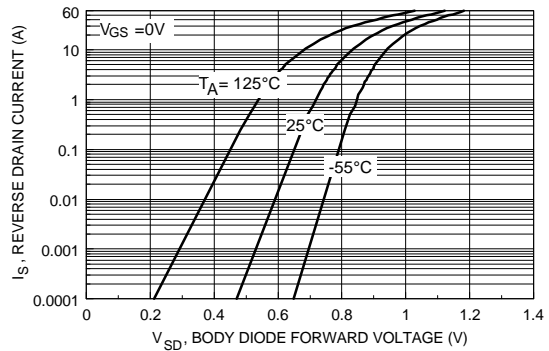


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

### Typical Electrical Characteristics (continued)

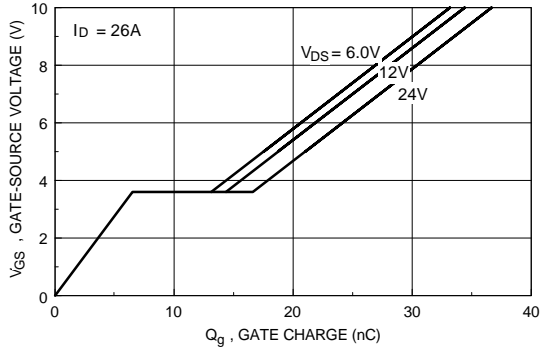


Figure 7. Gate Charge Characteristics.

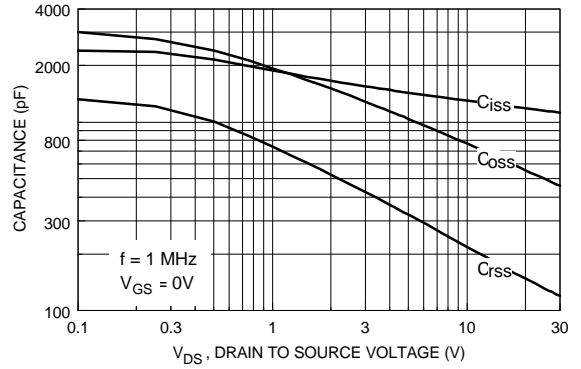


Figure 8. Capacitance Characteristics.

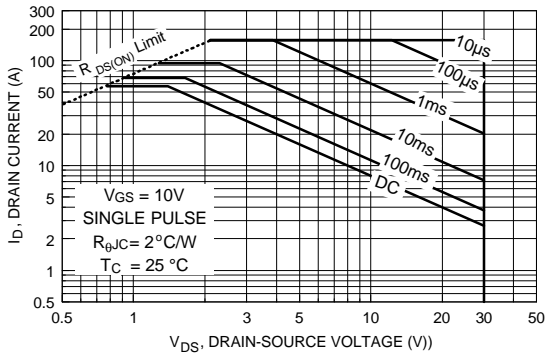


Figure 9. Maximum Safe Operating Area.

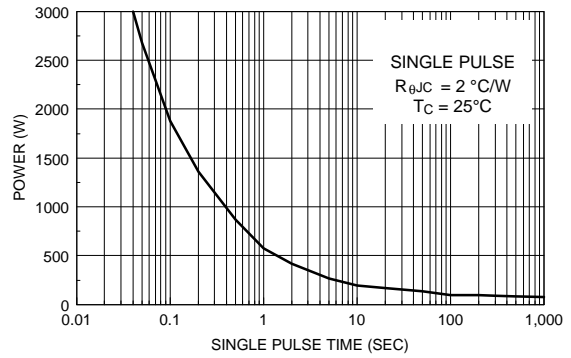


Figure 10. Single Pulse Maximum Power Dissipation.

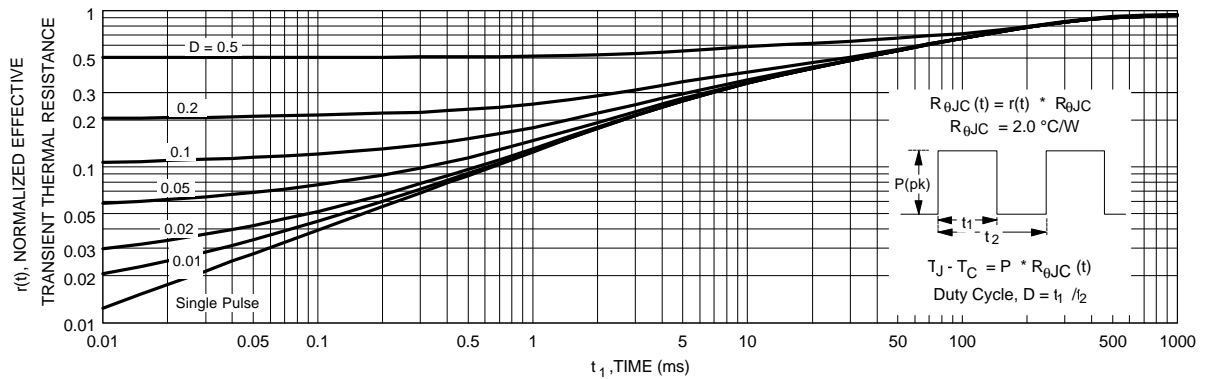


Figure 11. Transient Thermal Response Curve.

## TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

|                                   |                                  |                                  |                              |                   |
|-----------------------------------|----------------------------------|----------------------------------|------------------------------|-------------------|
| ACE <sub>x</sub> <sup>TM</sup>    | FAST <sup>®</sup>                | OPTOLOGIC <sup>TM</sup>          | SMART START <sup>TM</sup>    | VCX <sup>TM</sup> |
| Bottomless <sup>TM</sup>          | FAST <sub>r</sub> <sup>TM</sup>  | OPTOPLANAR <sup>TM</sup>         | STAR*POWER <sup>TM</sup>     |                   |
| CoolFET <sup>TM</sup>             | FRFET <sup>TM</sup>              | PACMAN <sup>TM</sup>             | Stealth <sup>TM</sup>        |                   |
| CROSSVOLT <sup>TM</sup>           | GlobalOptoisolator <sup>TM</sup> | POP <sup>TM</sup>                | SuperSOT <sup>TM</sup> -3    |                   |
| DenseTrench <sup>TM</sup>         | GTO <sup>TM</sup>                | Power247 <sup>TM</sup>           | SuperSOT <sup>TM</sup> -6    |                   |
| DOMET <sup>TM</sup>               | HiSeC <sup>TM</sup>              | PowerTrench <sup>®</sup>         | SuperSOT <sup>TM</sup> -8    |                   |
| EcoSPARK <sup>TM</sup>            | ISOPLANAR <sup>TM</sup>          | QFET <sup>TM</sup>               | SyncFET <sup>TM</sup>        |                   |
| E <sup>2</sup> CMOS <sup>TM</sup> | LittleFET <sup>TM</sup>          | QST <sup>TM</sup>                | TinyLogic <sup>TM</sup>      |                   |
| EnSigna <sup>TM</sup>             | MicroFET <sup>TM</sup>           | QT Optoelectronics <sup>TM</sup> | TruTranslation <sup>TM</sup> |                   |
| FACT <sup>TM</sup>                | MicroPak <sup>TM</sup>           | Quiet Series <sup>TM</sup>       | UHC <sup>TM</sup>            |                   |
| FACT Quiet Series <sup>TM</sup>   | MICROWIRE <sup>TM</sup>          | SILENT SWITCHER <sup>®</sup>     | UltraFET <sup>®</sup>        |                   |

STAR\*POWER is used under license

## DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

## LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

## PRODUCT STATUS DEFINITIONS

### Definition of Terms

| Datasheet Identification | Product Status         | Definition  |
|--------------------------|------------------------|---|
| Advance Information      | Formative or In Design | This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.  |
| Preliminary              | First Production       | This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design. |
| No Identification Needed | Full Production        | This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.   |
| Obsolete                 | Not In Production      | This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.   |

This datasheet has been download from:

[www.datasheetcatalog.com](http://www.datasheetcatalog.com)

Datasheets for electronics components.